

<b>Issue Classification</b>		Application/Control No.	Applicant(s)/Patent under Reexamination
		10/784,260	FUJIBAYASHI, AKIRA
Examiner		Art Unit	
Hiep T. Nguyen		2187	

ORIGINAL		CROSS REFERENCE(S)	
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)
711	170	711	162
INTERNATIONAL CLASSIFICATION		710	56
G	06	F	12100
/		/	
/		/	
/		/	
/		/	
 (Assistant Examiner) (Date)		Total Claims Allowed: 26	
 (Legal Instruments Examiner) (Date)		HIEP T. NGUYEN PRIMARY EXAMINER (Primary Examiner) 11/30/05	O.G. Print Claim(s) 1
			O.G. Print Fig. 1

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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